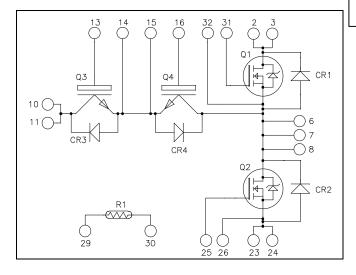
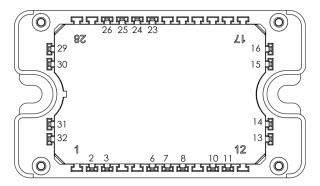


# Phase Leg & Dual Common Emitter Power Module





All multiple inputs and outputs must be shorted together 10/11; 23/24; 2/3; ...

### SiC MOSFET (Q1, Q2):

 $V_{CES} = 1200V ; R_{DSon} = 34m\Omega \max @ Tj = 25^{\circ}C$ 

## Trench & Field Stop IGBT3 (Q3, Q4):

 $V_{CES} = 600V$ ;  $I_C = 50A$  @  $T_C = 100$ °C

### Application

- Solar converter
- Uninterruptible Power Supplies

#### **Features**

- Q1, Q2 SiC Power MOSFET
  - Low R<sub>DS(on)</sub>
  - High temperature performance

### • Q3, Q4 Trench + field Stop IGBT3

- Low voltage drop
- Low tail current
- Switching frequency up to 20 kHz

### • SiC Schottky Diode (CR1 to CR4)

- Zero reverse recovery
- Zero forward recovery
- Temperature Independent switching behavior
- Positive temperature coefficient on VF
- Kelvin emitter for easy drive
- Very low stray inductance
- AlN substrate for improved thermal performance
- Internal thermistor for temperature monitoring

#### **Benefits**

- Stable temperature behavior
- Very rugged
- Solderable terminals for easy PCB mounting
- Direct mounting to heatsink (isolated package)
- Low junction to case thermal resistance
- Easy paralleling due to positive T<sub>C</sub> of V<sub>CEsat</sub>
- Low profile

### All ratings @ $T_j = 25^{\circ}C$ unless otherwise specified

CAUTION: These Devices are sensitive to Electrostatic Discharge. Proper Handling Procedures Should Be Followed. See application note APT0502 on www.microsemi.com

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### 1. SiC MOSFET characteristics (Per MOSFET)

### Absolute maximum ratings

Symbol	Parameter		Max ratings	Unit
$V_{ m DSS}$	Drain - Source Voltage		1200	V
Ţ	Continue Desire Consent		73	
$I_{\mathrm{D}}$	Continuous Drain Current	$T_c = 80$ °C	55	Α
$I_{DM}$	Pulsed Drain Current		140	
$V_{GS}$	Gate - Source Voltage		-10/+25	V
$R_{DSon}$	Drain - Source ON Resistance		34	$m\Omega$
$P_D$	Power Dissipation	$T_c = 25$ °C	375	W

### **Electrical Characteristics**

Symbol	Characteristic	Test Conditions		Min	Typ	Max	Unit
$I_{DSS}$	Zero Gate Voltage Drain Current	$V_{GS} = 0V$ , $V_{DS} = 120$			100	μΑ	
D	Drain – Source on Resistance	$V_{GS} = 20V$	$T_j = 25^{\circ}C$		25	34	
$R_{DS(on)}$		$I_D = 50A$	$T_{j} = 150^{\circ}C$		43		mΩ
$V_{GS(th)}$	Gate Threshold Voltage	$V_{GS} = V_{DS}, I_{D} = 12.5 \text{mA}$		2.4	3		V
$I_{GSS}$	Gate – Source Leakage Current	$V_{GS} = 20 \text{ V}, V_{DS} = 0 \text{ V}$	/			600	nA

### **Dynamic Characteristics**

Symbol	Characteristic	Test Conditions		Min	Тур	Max	Unit
$\begin{array}{c} C_{iss} \\ C_{oss} \\ C_{rss} \end{array}$	Input Capacitance Output Capacitance Reverse Transfer Capacitance	$\begin{aligned} \mathbf{V}_{\mathrm{GS}} &= 0\mathbf{V} \\ \mathbf{V}_{\mathrm{DS}} &= 1000\mathbf{V} \\ \mathbf{f} &= 1\mathbf{MHz} \end{aligned}$			2788 220 15		pF
$\begin{array}{c} Q_g \\ \\ Q_{gs} \\ \\ Q_{gd} \end{array}$	Total gate Charge  Gate – Source Charge  Gate – Drain Charge	$V_{GS} = -5/20V$ $V_{Bus} = 800V$ $I_D = 50A$			161 46 50		пС
$T_{d(on)}$ $T_{r}$ $T_{d(off)}$ $T_{f}$	Turn-on Delay Time Rise Time Turn-off Delay Time Fall Time	$V_{GS} = -2/+20V V_{Bus} = 800V I_D = 50A R_L = 16\Omega ; R_G = 20\Omega$	Ω		21 19 50 30		ns
E <sub>on</sub>	Turn on Energy	Inductive Switching $V_{GS} = -5/+20V$ $V_{Bus} = 600V$	$T_j = 150$ °C		1.1		m I
$E_{\text{off}}$	Turn off Energy	$I_D = 50A$ $R_G = 20\Omega$	$T_{j} = 150^{\circ}C$		0.6		mJ
$R_{\text{thJC}}$	Junction to Case Thermal Resistance	)		·		0.4	°C/W



### SiC diode ratings and characteristics (CR1 & CR2) (per diode)

Symbol	Characteristic	Test Conditions		Min	Typ	Max	Unit
$V_{RRM}$	Peak Repetitive Reverse Voltage					1200	V
T	Reverse Leakage Current	$V_R = 1200V$	$T_j = 25^{\circ}C$		10	200	^
$I_{RM}$		V <sub>R</sub> -1200V	$T_{j} = 175^{\circ}C$		500		μΑ
$I_F$	DC Forward Current		Tc = 100°C		10		A
$V_{\rm F}$	Diede Ferryand Voltage	ge $I_F = 10A \qquad \frac{T_i = 25^{\circ}C}{T_i = 175^{\circ}C}$	$T_i = 25^{\circ}C$		1.5	1.8	V
<b>v</b> <sub>F</sub>	Diode Forward Voltage		$T_i = 175^{\circ}C$		2.3		V
Qc	Total Capacitive Charge	$I_F = 10A, V_R = 600V$ $di/dt = 500A/\mu s$			120		nC
C	T + 1 C · ·	$f = 1 MHz, V_R = 2$	200V		115		ъE
C	Total Capacitance $f = 1MH$		400V		85		pF
$R_{thJC}$	Junction to Case Thermal Resistance					1.1	°C/W

### 2. Trench & Field Stop IGBT3 (per IGBT)

### **Absolute maximum ratings**

Symbol	Parameter		Max ratings	Unit
$V_{CES}$	Collector - Emitter Voltage		600	V
т	Continuous Collector Current	$T_C = 25^{\circ}C$	105	
$I_{C}$	Continuous Conector Current	$T_{\rm C} = 100^{\circ}{\rm C}$	50	A
$I_{CM}$	Pulsed Collector Current	$T_C = 25^{\circ}C$	100	
$ m V_{GE}$	Gate – Emitter Voltage		±20	V
$P_{D}$	Power Dissipation	$T_C = 25^{\circ}C$	176	W
RBSOA	Reverse Bias Safe Operating Area	$T_J = 150$ °C	100A @ 550V	

### **Electrical Characteristics**

Symbol	Characteristic	Test Conditions	Min	Typ	Max	Unit	
$I_{CES}$	Zero Gate Voltage Collector Current	$V_{GE} = 0V, V_{CE} = 600V$				25	μΑ
V	Collector Emitter Saturation Voltage	$V_{GE} = 15V$	$T_j = 25^{\circ}C$		1.5	1.9	V
$V_{CE(sat)}$		$I_C = 50A$	$T_{j} = 150^{\circ}C$		1.7		V
V <sub>GE(th)</sub>	Gate Threshold Voltage	$V_{GE} = V_{CE}, I_{C} = 600 \mu A$		5.0	5.8	6.5	V
$I_{GES}$	Gate – Emitter Leakage Current	$V_{GE} = 20V, V_{CE}$	= 0V			600	nA

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**Dynamic Characteristics** 

Symbol	Characteristic	Test Conditions		Min	Тур	Max	Unit
Cies	Input Capacitance	$V_{GE} = 0V$			3150		
$C_{oes}$	Output Capacitance	$V_{CE} = 25V$			200		pF
$C_{res}$	Reverse Transfer Capacitance	f = 1MHz			95		
$Q_{G}$	Gate charge	$V_{GE} = \pm 15V, I_{C} = V_{CE} = 300V$	= 50A		500		nC
$T_{d(on)}$	Turn-on Delay Time	Inductive Switch	ning (25°C)		110		
$T_{\rm r}$	Rise Time	$V_{GE} = \pm 15V$			45		
$T_{d(off)}$	Turn-off Delay Time	$V_{\text{Bus}} = 300V$ $I_{\text{C}} = 50A$			200		ns
$T_{\rm f}$	Fall Time	$R_G = 8.2\Omega$		40			
$T_{d(on)}$	Turn-on Delay Time	Inductive Switching (150°C)			120		
$T_{\rm r}$	Rise Time	$V_{GE} = \pm 15V$			50		
$T_{d(off)}$	Turn-off Delay Time	$V_{\text{Bus}} = 300V$ $I_{\text{C}} = 50A$			250		ns
$T_{\mathrm{f}}$	Fall Time	$R_G = 8.2\Omega$			60		
E <sub>on</sub>	Turn-on Switching Energy	$V_{GE} = \pm 15V$	$T_j = 25^{\circ}C$		0.2		mJ
Lon	Turn-on Switching Energy	$V_{Bus} = 300V$	$T_j = 150$ °C		0.26		1113
$E_{off}$	Turn-off Switching Energy	$I_C = 50A$	$T_j = 25^{\circ}C$		1.35		mJ
Doff	Turn on Switching Energy	$R_G = 8.2\Omega$	$T_j = 150$ °C		1.75		1113
$I_{sc}$	Short Circuit data	$V_{GE} \le 15V$ ; $V_{Bus} = 360V$ $t_p \le 10\mu s$ ; $T_i = 150^{\circ}C$			250		A
$R_{thJC}$	Junction to Case Thermal Resistance					0.68	°C/W

### 3. SiC diode ratings and characteristics (CR3 & CR4) (per diode)

Symbol	Characteristic	Test Conditions	Test Conditions		Typ	Max	Unit
$V_{RRM}$	Peak Repetitive Reverse Voltage					600	V
T	Reverse Leakage Current	$V_{R} = 600V$	$T_j = 25^{\circ}C$		20	120	^
$I_{RM}$		v <sub>R</sub> – 600 v	$T_j = 175$ °C		40	600	μΑ
$I_F$	DC Forward Current		Tc = 100°C		20		Α
$V_{\mathrm{F}}$	Diode Forward Voltage	$I_F = 20A$	$T_i = 25^{\circ}C$		1.6	1.8	V
V <sub>F</sub>		$T_{i} = 175^{\circ}C$			2	2.4	v
Qc	Total Capacitive Charge	$I_F = 20A, V_R = 600V$ $di/dt = 800A/\mu s$			56		nC
С	Total Capacitance	$f = 1 MHz, V_R = 200V$ $f = 1 MHz, V_R = 400V$			130		ъE
					100		pF
$R_{thJC}$	Junction to Case Thermal Resistance					1.1	°C/W

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### 4. Temperature sensor NTC

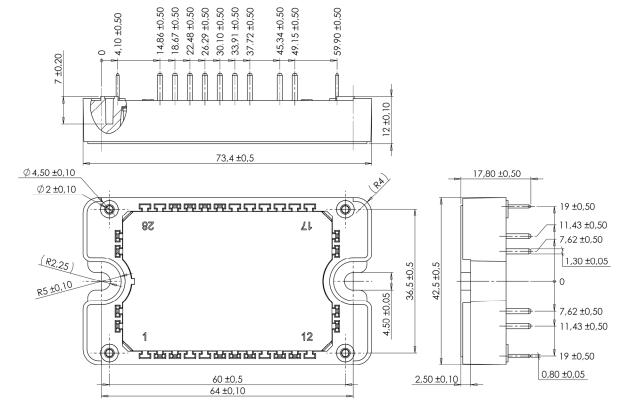
Symbol	Characteristic	Min	Тур	Max	Unit
R <sub>25</sub>	Resistance @ 25°C		22		kΩ
$\Delta R_{25}/R_{25}$	Resistance tolerance			5	%
$\Delta B/B$	Beta tolerance			3	70
${ m B}_{25/100}$	$T_{25} = 298.16 \text{ K}$		3980		K

$$R_T = \frac{R_{25}}{\exp \left[ B_{25/100} \left( \frac{1}{T_{25}} - \frac{1}{T} \right) \right]}$$
 T: Thermistor temperature R<sub>T</sub>: Thermistor value at T

### 5. Thermal and package characteristics

Symbol	Characteristic			Min	Max	Unit
$V_{ISOL}$	RMS Isolation Voltage, any terminal to case	e t = 1 min, 50/6	60Hz	4000		V
Т	Operating junction temperature range		OSFET	-40	150	
$T_{J}$	Operating junction temperature range	SiC di	ode + IGBT	-40	175	
$T_{JOP}$	Recommended junction temperature under switching conditions				T <sub>J</sub> max -25	°C
$T_{STG}$	Storage Temperature Range			-40	125	
$T_{\rm C}$	Operating Case Temperature			-40	125	
Torque	Mounting torque	To heatsink	M4	2	3	N.m
Wt	Package Weight				110	g

### Package outline (dimensions in mm)



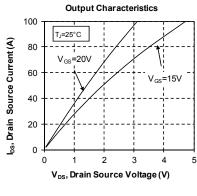
See application note 1906 - Mounting Instructions for SP3F Power Modules on www.microsemi.com

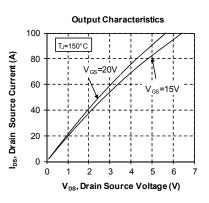
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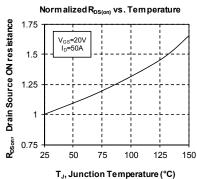


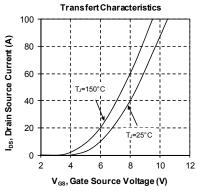
### 6. Typical performance curve

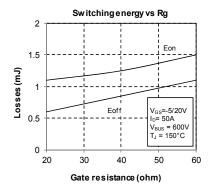
### Q1, Q2 SiC MOSFET

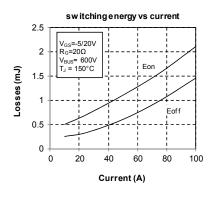


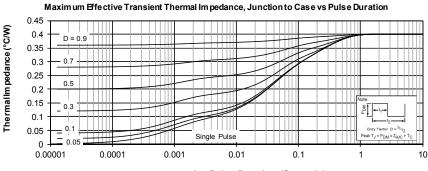










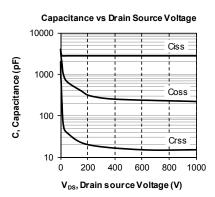


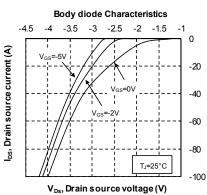
rectangular Pulse Duration (Seconds)

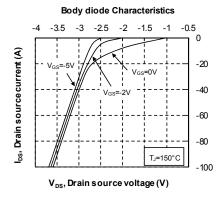
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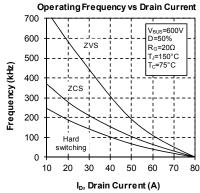
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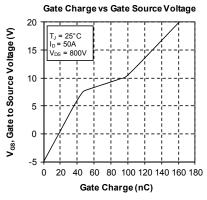


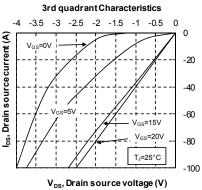


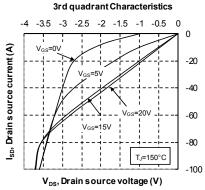








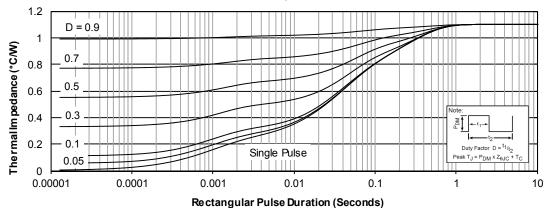


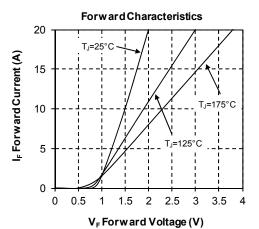


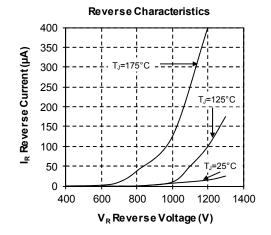


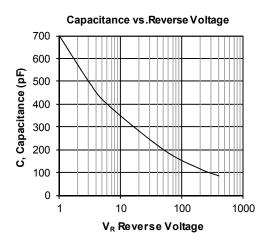
### CR1 & CR2 SiC diode characteristics

#### Maximum Effective Transient Thermal Impedance, Junction to Case vs Pulse Duration



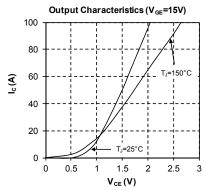


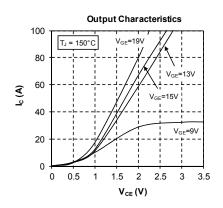


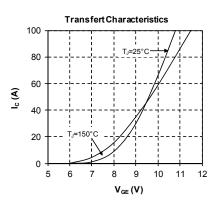


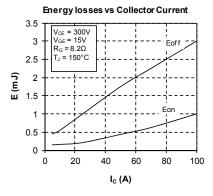


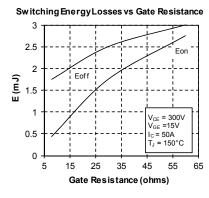
### Q3, Q4 Trench + field stop IGBT3

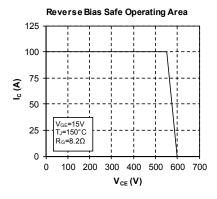


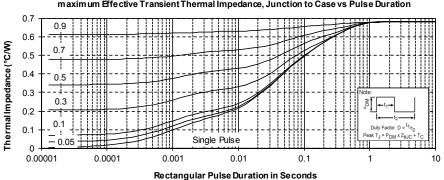












maximum Effective Transient Thermal Impedance, Junction to Case vs Pulse Duration

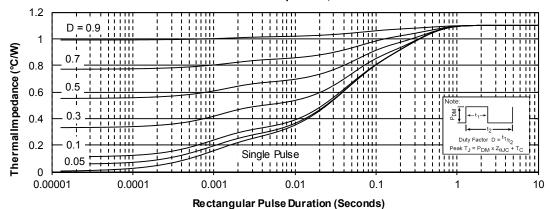
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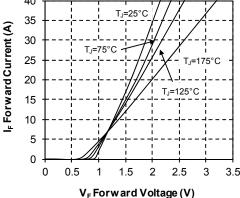


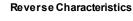
### CR3 & CR4 SiC diode characteristics

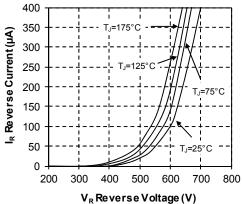
#### Maximum Effective Transient Thermal Impedance, Junction to Case vs Pulse Duration

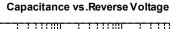


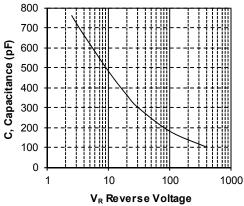
Forward Characteristics 40 35 30 25













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